

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/605,613	LIU ET AL.	
Examiner	Art Unit	
Alexander S. Beck	2629	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	4/21/2006	ASB		
341/22,175,176 (text search only - see search history printout)	4/21/2006	ASB		
345/156,168,169 (text search only - see search history printout)	4/21/2006	ASB		
367/117,197 (text search only - see search history printout)	4/21/2006	ASB		
400/472 (text search only - see search history printout)	4/21/2006	ASB		
455/151.4 (text search only - see search history printout)	4/21/2006	ASB		